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INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Filing Date	May 15, 2001	
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				Group Art Unit	2829	
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Sheet	1	of	1	Attorney Docket Number	11157-23	

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Examiner Signature	Timmy Nowyen	Date Considered	614/03	

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¹ Applicant's unique citation designation number (optional) . ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (MPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Complete if Known 09/854,905 Application Number May 15, 2001 Filing Date MOORE, Brian First Named Inventor 2829 Group Art Unit **Examiner Name**

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				Group Art Unit	2829	
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